

<b>Notice of References Cited</b>	Application/Control No. 10/053,987	Applicant(s)/Patent Under Reexamination LEMON ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,775,671	08-2004	de Lara et al.	707/10
	B	US-6,711,585	03-2004	Copperman et al.	707/104.1
	C	US-6,640,249	10-2003	Bowman-Amuah, Michel K.	709/228
	D	US-6,640,244	10-2003	Bowman-Amuah, Michel K.	709/207
	E	US-6,721,795	04-2004	Eldreth, Paul	709/232
	F	US-6,865,582	03-2005	Obradovic et al.	707/104.1
	G	US-6,836,773	12-2004	Tamayo et al.	707/6
	H	US-6,745,185	06-2004	Lee et al.	707/6
	I	US-6,718,338	04-2004	Vishnubhotla, Prasad Rajendra	707/102
	J	US-6,477,565	11-2002	Daswani et al.	709/217
	K	US-6,477,538	11-2002	Yaginuma et al.	707/102
	L	US-6,473,741	10-2002	Baker, Samuel R.	705/31
	M	US-6,470,352	10-2002	Yaginuma, Yoshinori	707/102

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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